



Electronic Testing of the Droplet Presence

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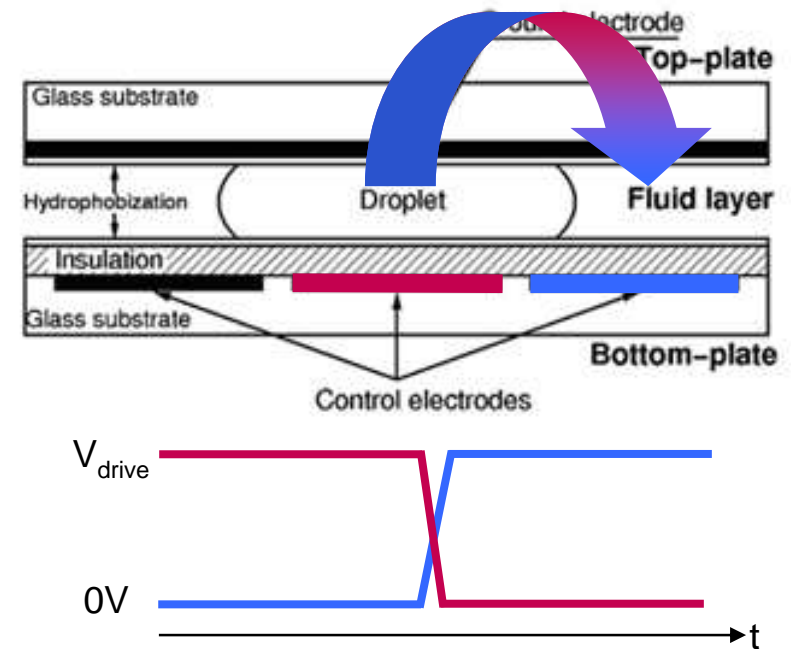
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«Design for Micro & Nano Manufacture (NoE PATENT-DfMM)»
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- Introduction
- State of the art*
 - Fault classification
 - catastrophic faults
 - parametric faults
 - Testing principles of droplet-based microfluidic array
- Electronic architectures for testing the droplet motion
 - Duke university architecture
 - LIRMM proposal
- Conclusion

* Duke University: F. Su, S. Ozev and K. Chakrabarty, "Ensuring the operational health of droplet-based microelectrofluidic biosensor systems", IEEE Sensors, vol. 5, pp. 763-773, August 2005

- Testing principle : based on using a test fluid and verifying the droplet motion when V_{drive} is applied
- Catastrophic fault = fluid motion inhibition
- Droplet motion could be detected by measuring the capacitance between top and blue electrodes \Rightarrow on-chip electronics



State of the art

- ❑ Catastrophic faults
 - Dielectric breakdown of the hydrophobic insulator
 - short circuit between droplet and electrode
 - no charge can be stored at the interface
 - no electrowetting mechanism
 - Short between adjacent electrodes
 - lead to a larger electrode
 - droplet is not large enough to overlap the 2 electrodes
 - Degradation of the electrode
 - fragmentation of the droplet
 - no motion due to the variation of surface tension forces
 - Open in metal interconnections
 - failure in charging electrode

- Parametric faults lead to variations of the droplet velocity (u)

given by the balance between the work done by the surface tension gradient and power dissipation*:

$$\frac{\epsilon_0 \epsilon_R}{2d} V_{drive}^2 - F_T = B \gamma_{LM} \left(\frac{\mu_D u}{\gamma_{LM}} \right)^{0.3} + \left(\frac{mL}{h} + s \right) \mu_0 u + \zeta u$$

external force (per unit length)	threshold initiation force	viscous dissipation	viscosity of the filler fluid	friction fluid/ insulator
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$\epsilon_0 \epsilon_R$: insulator permittivity

d : insulator thickness

γ_{LM} : liquid-medium interfacial tension constant

L : electrode length

μ_D, μ_0 : viscosity of droplet and filler fluid

h : capacitor height

B, m, s, ζ : fluidic constants

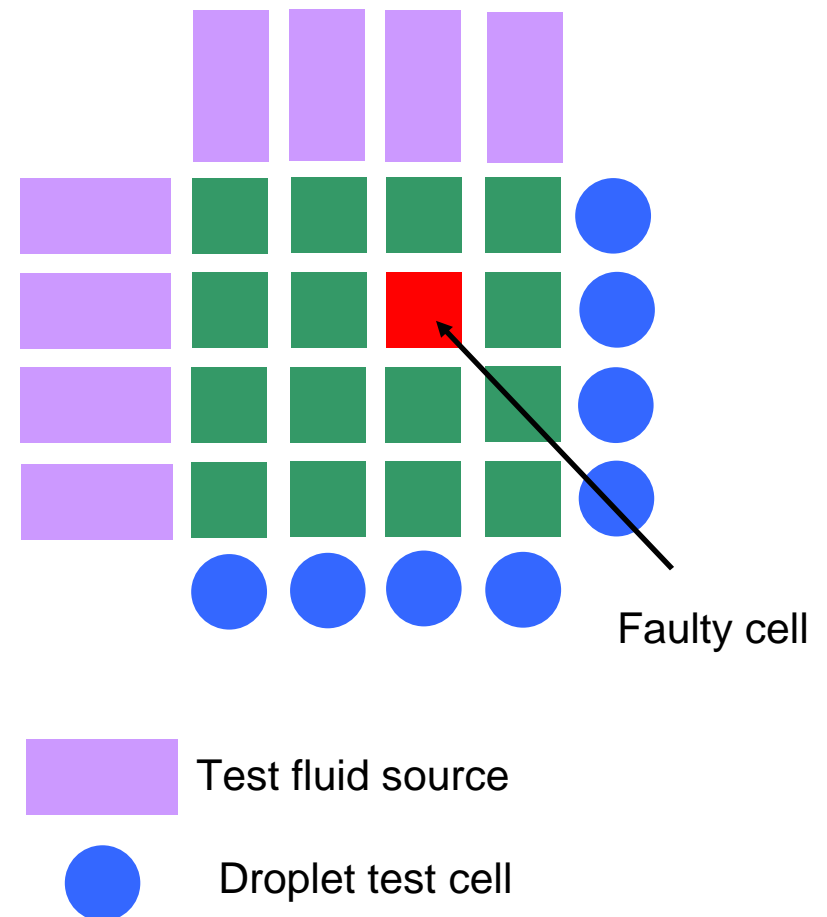
* H. Ren, R.B. Fair, M.G. Pollack, E.J. Shaughnessy, Sensors and Actuators B 87 (2002) 201-206.

- Variation of one of these parameters will impact the droplet velocity by changing the external force or a dissipation term
 - Particule contamination (dust particle, foreign fluid droplet) : reduce the droplet velocity and change the cell capacitance
 - Defect in the temperature controller during a biological/chemical reaction: impact on fluid viscosity and then on fluid velocity
 - Voltage supply: modify external motion force
- ⇒ verification of the droplet velocity permits to detect all these parametric faults

- First method proposed by Duke: very simple to implement
 - first, droplets are driven along the x axis and are detected at the end of the row by the droplet test cells if there is no faulty cell on the row
 - second, same operation is done along the y axis

ex: no droplet is detected for the row 2 and the column 3 due to the faulty cell

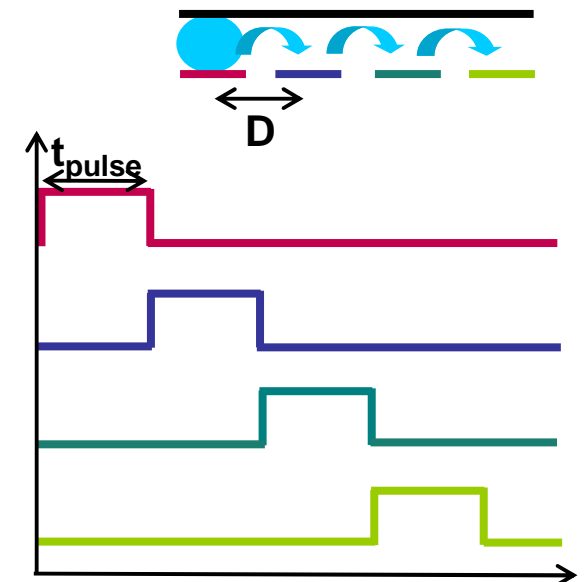
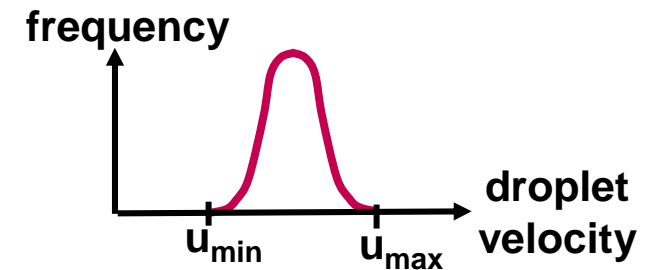
⇒ using more complex algorithms, method can be extended for detecting multiple faulty cells or for on-line monitoring



- Monte-carlo analysis:
 - standard deviation of all the parameters
 - ⇒ deviation of droplet velocity

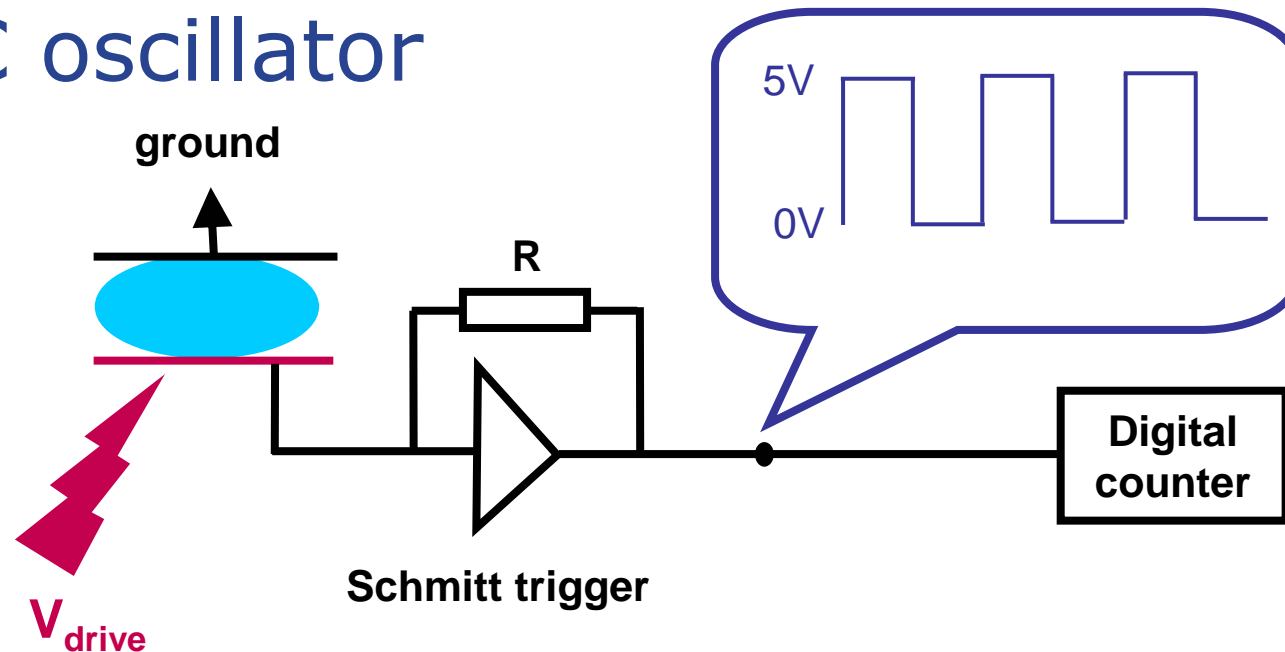
- Test based on pulse duration:
 - if $t_{\text{pulse}} = D/u_{\text{min}}$: motion should always be detected (pulse is large enough for moving slowest droplets)
 - if $t_{\text{pulse}} < D/u_{\text{max}}$: no motion should be detected

⇒ For parametric or catastrophic fault testing, on-chip electronics detection of the droplet is necessary



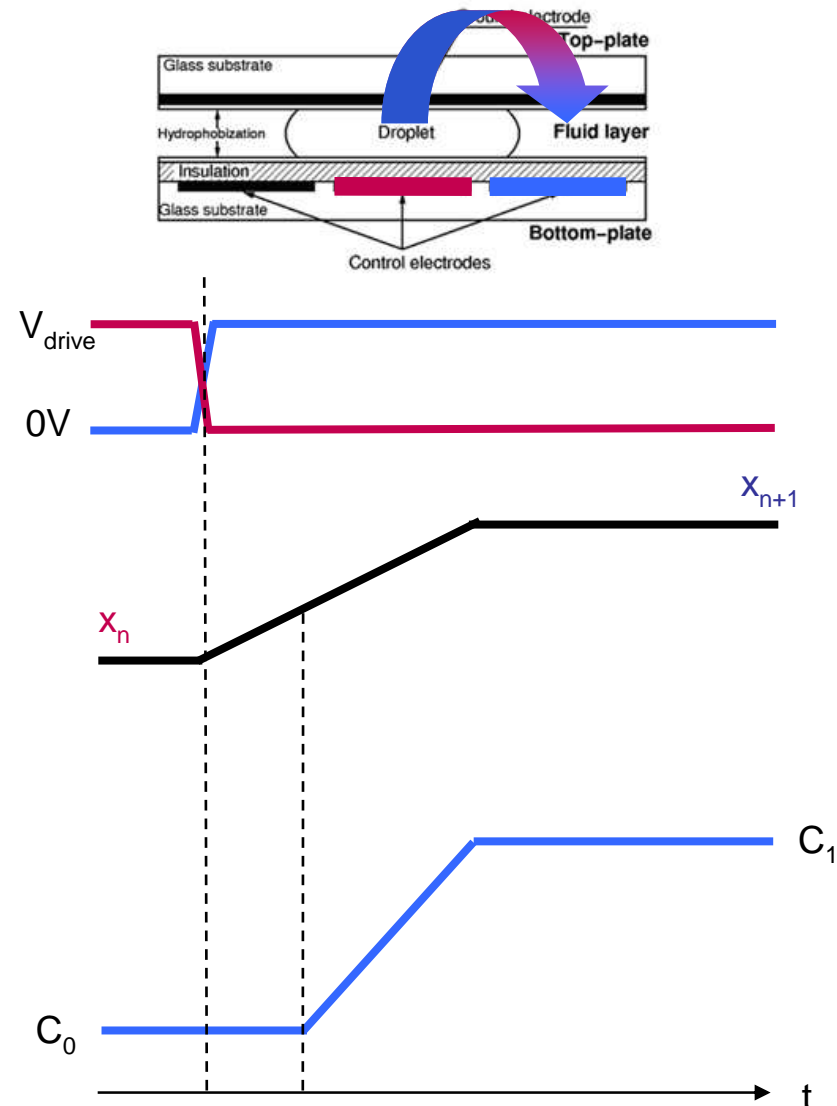
Electronic architectures for testing the droplet motion

RC oscillator



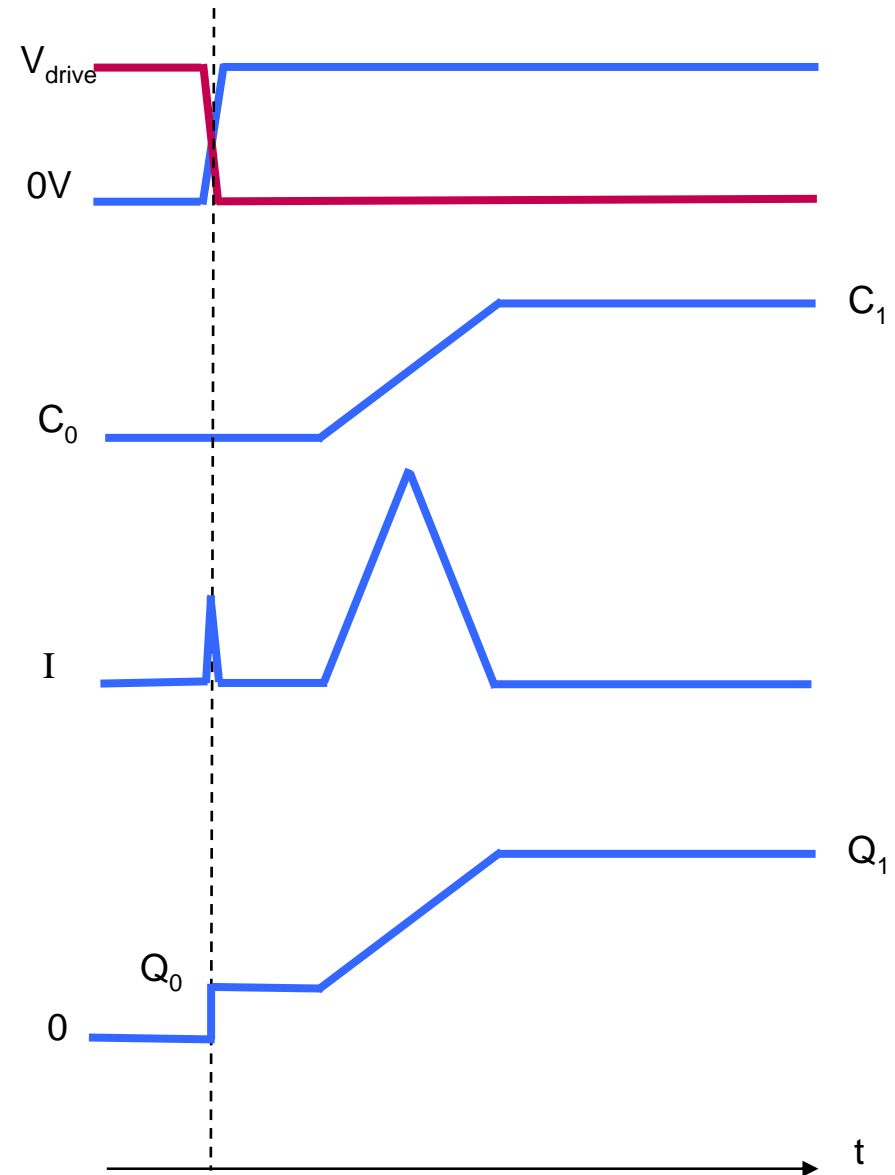
- only used to detect the droplet presence (simple pass/fail criteria)
- no information about high voltage decoupling: no effect on oscillator operating ?

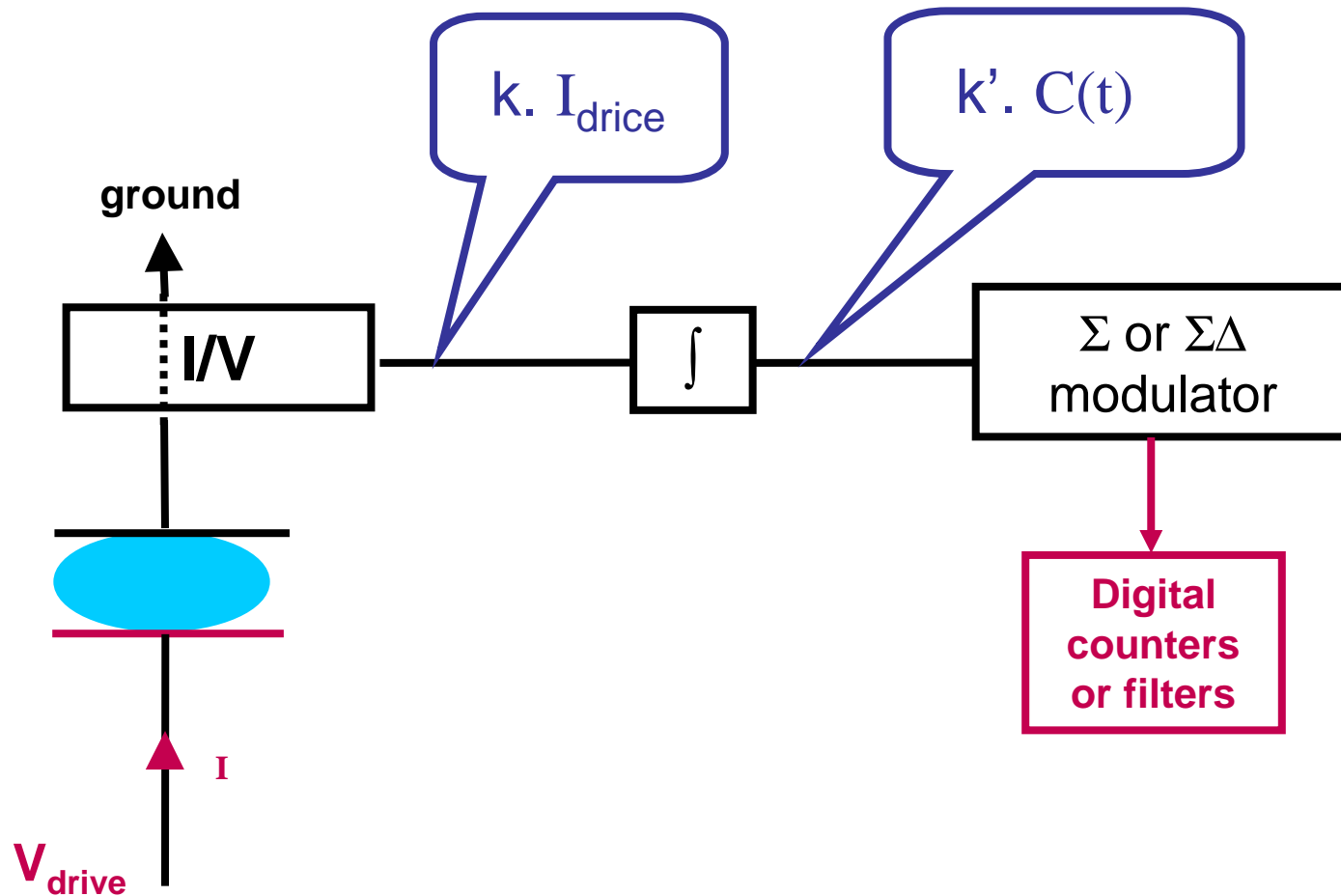
- Our aim: use the same circuit for test and measurement of:
 - capacitance value before droplet arrival (C_0)
 - capacitance value with the droplet presence (C_1)
 - droplet velocity (u)
 - capacitance value due to droplet contents (ΔC_1)



Principle:

- current tracking
- $Q = C(t) \cdot V_{\text{drive}}$
 $= \int I_{\text{drive}} \cdot dt$





- Current drive tracking should allow droplet presence testing, parametric fault detection and droplet contents measurement.
- To start the circuit implementation, we need some entries:
 - design kits of the CMOS/DMOS technology
 - high voltage circuit implemented on the prototype
 - experimental or simulated values of the capacitances: C_0 and C_1
 - model for droplet transfer: $C(t)$
 - measurement resolution necessary for droplet contents analysis